

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Eui-Hyeok Yang et al

Art Unit: 2812

Serial No.: 10/005,765

Examiner : Unknown

Filed

: November 2, 2001

Title

: WAFER-LEVEL TRANSFER OF MEMBRANES IN SEMICONDUCTOR

PROCESSING

Commissioner for Patents Washington, D.C. 20231

INFORMATION DISCLOSURE STATEMENT

Dear Sir:

Applicants call attention to the attached Information Disclosure Statement and documents listed on form PTO-1449.

This filing is being made before the receipt of a first Office action on the merits. No fee is required.

The documents are in the English language; hence no concise explanation is necessary per Rule 98(a)(3).

Please apply any charges or credits to Deposit Account No. 06-1050.

CERTIFICATE OF MAILING BY FIRST CLASS MAIL

I hereby certify under 37 CFR §1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated below and is addressed to the Commissioner for Patents, Washington, D.C. 20231.

March

Signature

Sharon Gebhart

Typed or Printed Name of Person Signing Certificate

Attorney's Docket No.: 06618-720001 / CIT-3325

Consideration of the foregoing and enclosures plus the return of a copy of the enclosed form PTO-1449 with the Examiner's initials in the left column per MPEP 609 are earnestly solicited along with an early action on the merits.

Respectfully submitted, `

Date: March 28, 2002

BING AI

Scott C. Harris Reg. No. 32,030 REG. NO 43,312

Fish & Richardson P.C. PTO Customer No. 20985 4350 La Jolla Village Drive, Suite 500 San Diego, CA 92122

Telephone: (858) 678-5070 Facsimile: (858) 678-5099

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Substitute Form PTO-1449 (Modified)

U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. App 06618-720001

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APR 1 8 2017 formation Disclosure Statement by Applicant
Use several sheets if necessary)

Applicant Eui-Hyeok Yang and Dean V. Wiberg

Filing Date

November 2, 2001

Group Art Unit 2812

U.S. Patent Documents							
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG	30 to 1					
	AH			-			
	AI						

Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	lation No
	AJ						
	AK					-t-h-t-	
	AL						

Other Documents (include Author, Title, Date, and Place of Publication)				
Examiner Initial	Desig. ID	Document 6/		
	AM	K.F. Harsh, W. Zhang, V.M. Bright and Y.C. Lee, "Flip-Chip Assembly for Si-Based RF MEMS", Proc. MEMS '99, Orlando, Florida, pp. 273-278, Jan 1999		
	AN	T. Akiyama, U. Stzufer and N de Rooij, "Wafer-and Piece-Wise Si Tip Transfer Technologies for Applications in Scanning Probe Microscopy", IEEE Journal of Microelectromechanical Systems, pp. 65-70, 1999		
	AO	A. Singh, D.A. Horsley, M. Cohn, A. Pisano and R.T. Howe, "Batch Transfer of Microstructures using Flip-Chip Solder Bonding", IEEE Journal of Microelectromechanical Systems, pp. 27-33 1999.		
	AP	H. Nguyen, P. Patterson, H. Toshiyoshi and M.C. Wu, "A Substrate-Independent Wafer Transfer Technique for Surface-Micromachined Devices", Proc MEMS Conference, 2000		

Examiner Signature	Date Considered			
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with				

next communication to applicant.